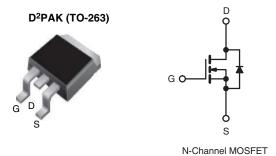
Vishay Siliconix

HALOGEN

FREE

S Series Power MOSFET

| PRODUCT SUMMARY | | | | | |
|--|------------------------|-------|--|--|--|
| V _{DS} at T _J max. (V) | 650 | | | | |
| R _{DS(on)} max. at 25 °C (Ω) | V _{GS} = 10 V | 0.190 | | | |
| Q _g max. (nC) | 98 | | | | |
| Q _{gs} (nC) | 17 | | | | |
| Q _{gd} (nC) | 25 | | | | |
| Configuration | Single | | | | |



FEATURES

- · Generation one
- High E_{AR} capability
- Lower figure-of-merit Ron x Qa
- 100 % avalanche tested
- Ultra low Ron
- dV/dt ruggedness
- Ultra low gate charge (Q_q)
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

APPLICATIONS

- PFC power supply stages
- · Hard switching topologies
- Solar inverters
- UPS
- Motor control
- Lighting
- Server telecom

| ORDERING INFORMATION | | | |
|---------------------------------|-----------------------------|--|--|
| Package | D ² PAK (TO-263) | | |
| Lead (Pb)-free and Halogen-free | SiHB22N60S-GE3 | | |
| Lead (Pb)-free | SiHB22N60S-E3 | | |

| PARAMETER | SYMBOL | LIMIT | UNIT | | | |
|--|-------------------------|--------------------------------|-----------------------------------|-------------|-------|--|
| Drain-Source Voltage | | | V_{DS} | 600 | | |
| Gate-Source Voltage | | | V _{GS} | ± 30 | V | |
| Continuous Drain Current | V _{GS} at 10 V | T _C = 25 °C | I- | 22 | | |
| Continuous Drain Current | | T _C = 100 °C | I _D | 13 | Α | |
| Pulsed Drain Current ^a | | | I _{DM} | 65 | | |
| Linear Derating Factor | | | | 2 | W/°C | |
| Single Pulse Avalanche Energy b | | | E _{AS} | 690 | | |
| Repetitive Avalanche Energy ^a | | | E _{AR} | 25 | — mJ | |
| Maximum Power Dissipation | | D ² PAK (TO-263) | P _D | 250 | W | |
| Drain-Source Voltage Slope | T _J = 125 °C | | d\//dt | 37 | 1//20 | |
| Reverse Diode dV/dt ^d | | | dV/dt | 5.3 | V/ns | |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | -55 to +150 | °C | |
| Soldering Recommendations (Peak Temperature) c | for 10 s | | | 300 | 7 | |

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature.
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 Ω , I_{AS} = 7 A.
- c. 1.6 mm from case.
- d. $I_{SD} \le I_D$, $dI/dt = 100 \text{ A/}\mu\text{s}$, starting $T_J = 25 \,^{\circ}\text{C}$.



Vishay Siliconix

| THERMAL RESISTANCE RATINGS | | | | | | |
|----------------------------------|-----------------------------|-------------------|------|------|------|--|
| PARAMETER | | SYMBOL | TYP. | MAX. | UNIT | |
| Maximum Junction-to-Ambient | D ² PAK (TO-263) | R_{thJA} | - | 62 | °C/W | |
| Maximum Junction-to-Case (Drain) | D ² PAK (TO-263) | R _{thJC} | - | 0.5 | | |

| PARAMETER | SYMBOL | TES | MIN. | TYP. | MAX. | UNIT | |
|---|---|---|-----------------------|------|-------|-------|----|
| Static | | | | • | | | |
| Drain-Source Breakdown Voltage | V_{DS} | V_{GS} | 600 | - | - | V | |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | Referenc | - | 0.70 | - | V/°C | |
| Gate-Source Threshold Voltage (N) | V _{GS(th)} | $V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$ | | 2.0 | - | 4.0 | V |
| Gate-Source Leakage | I _{GSS} | $V_{GS} = \pm 20 \text{ V}$ $V_{GS} = \pm 30 \text{ V}$ | | - | - | ± 100 | nA |
| | | | | - | - | ± 1 | μΑ |
| Z. v. Osta Valla v. Busis O. v. d | I _{DSS} | V _{DS} = 600 V, V _{GS} = 0 V | | - | - | 1 | μА |
| Zero Gate Voltage Drain Current | | V _{DS} = 600 V | - | - | 100 | | |
| Drain-Source On-State Resistance | R _{DS(on)} | V _{GS} = 10 V | I _D = 11 A | - | 0.160 | 0.190 | Ω |
| Forward Transconductance a | 9 _{fs} | V _{DS} = 50 V, I _D = 13 A | | - | 9.4 | - | S |
| Dynamic | | | | | | | |
| Input Capacitance | C_{iss} | $V_{GS} = 0 \text{ V}, \\ V_{DS} = 25 \text{ V}, \\ f = 1.0 \text{ MHz}$ $V_{GS} = 0 \text{ V} \qquad V_{DS} = 0 \text{ V to } 480 \text{ V}$ | | - | 2810 | - | pF |
| Output Capacitance | C _{oss} | | | - | 1480 | - | |
| Reverse Transfer Capacitance | C_{rss} | | | - | 33 | - | |
| Effective Output Capacitance (Time Related) | C _{oss eff.} (TR) ^a | | | - | 155 | - | |
| Total Gate Charge | Q_g | | | - | 75 | 110 | |
| Gate-Source Charge | Q_{gs} | $V_{GS} = 10 \text{ V}$ $I_D = 22 \text{ A}, V_{DS} = 480 \text{ V}$ | - | 17 | - | nC | |
| Gate-Drain Charge | Q _{gd} | | | - | 25 | - | 1 |
| Turn-On Delay Time | t _{d(on)} | $V_{DD} = 380 \text{ V}, I_{D} = 22 \text{ A},$ $R_{g} = 9.1 \Omega, V_{GS} = 10 \text{ V}$ | | - | 24 | 50 | ns |
| Rise Time | t _r | | | - | 68 | 100 | |
| Turn-Off Delay Time | t _{d(off)} | | | - | 77 | 115 | |
| Fall Time | t _f | | | - | 59 | 90 | |
| Gate Input Resistance | R_g | f = 1 MHz, open drain | | - | 0.65 | - | Ω |
| Drain-Source Body Diode Characteristic | es | | | | | | |
| Continuous Source-Drain Diode Current | I _S | MOSFET symbol showing the integral reverse p - n junction diode | | - | - | 22 | A |
| Pulsed Diode Forward Current | I _{SM} | | | - | - | 88 | |
| Diode Forward Voltage | V_{SD} | T _J = 25 °C, I _S = 22 A, V _{GS} = 0 V | | - | - | 1.2 | V |
| Reverse Recovery Time | t _{rr} | T _J = 25 °C, I _F = I _S , dI/dt = 100 A/µs, V _R = 25 V | | - | 462 | 690 | ns |
| Reverse Recovery Charge | Q _{rr} | | | - | 8.3 | 16 | μC |
| Reverse Recovery Current | I _{RRM} | | | - | 30 | 60 | Α |

Note

a. $C_{oss\,eff.}$ (TR) is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

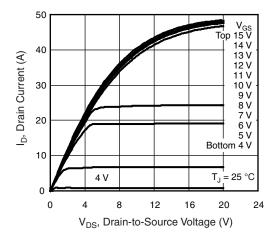


Fig. 1 - Typical Output Characteristics, T_J = 25 °C

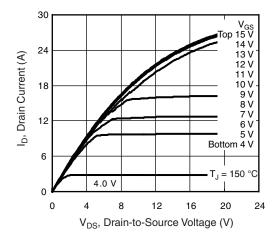


Fig. 2 - Typical Output Characteristics, T_J = 150 °C

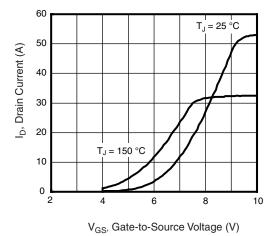


Fig. 3 - Typical Transfer Characteristics

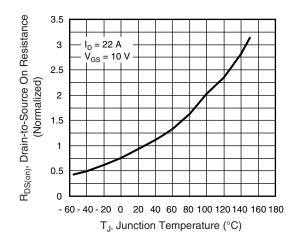


Fig. 4 - Normalized On-Resistance vs. Temperature

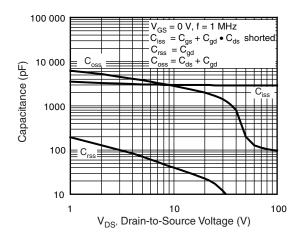


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

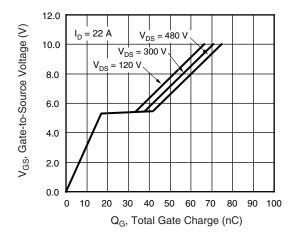


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



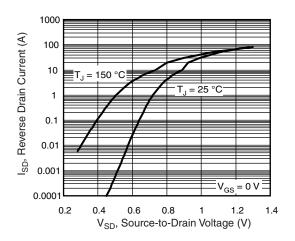


Fig. 7 - Typical Source-Drain Diode Forward Voltage

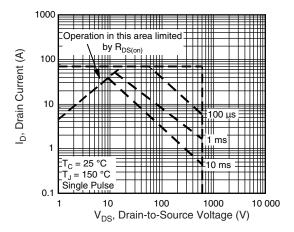


Fig. 8 - Maximum Safe Operating Area

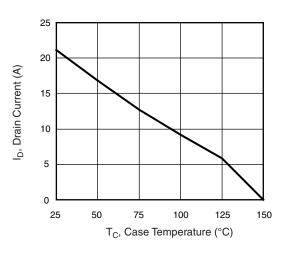


Fig. 9 - Maximum Drain Current vs. Case Temperature

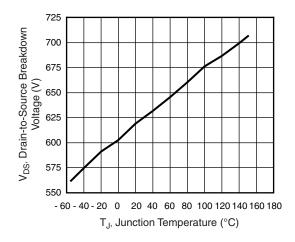


Fig. 10 - Drain-to-Source Breakdown Voltage

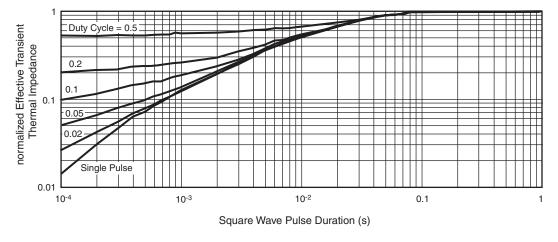


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



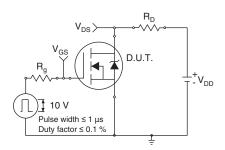


Fig. 12 - Switching Time Test Circuit

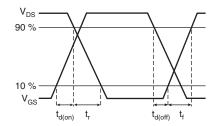


Fig. 13 - Switching Time Waveforms

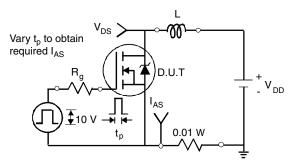


Fig. 14 - Unclamped Inductive Test Circuit

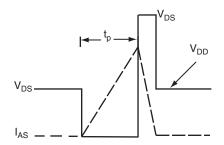


Fig. 15 - Unclamped Inductive Waveforms

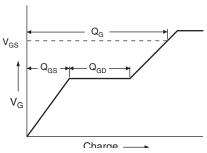


Fig. 16 - Basic Gate Charge Waveform

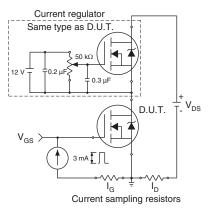
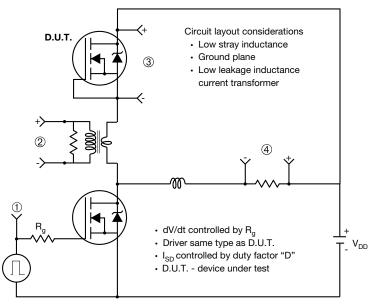


Fig. 17 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



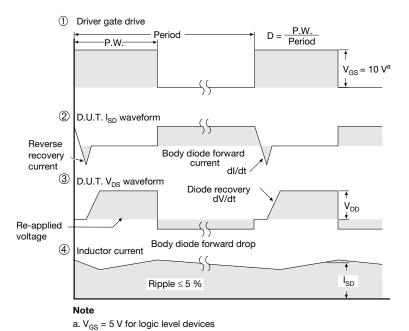


Fig. 18 - For N-Channel

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